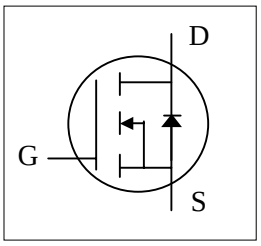
AP04N80I-HF

Halogen-Free Product

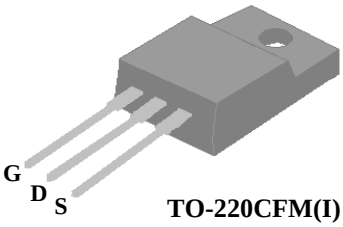
Advanced Power Electronics Corp.

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

- ▼ **100% Avalanche Test**
- ▼ **Fast Switching Characteristic**
- ▼ **Simple Drive Requirement**
- ▼ **RoHS Compliant**



BV_{DSS}	800V
$R_{DS(ON)}$	4.5Ω
I_D	3.2A



TO-220CFM(I)

Description

AP04N80 series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

TO-220CFM type provide high blocking voltage to overcome voltage surge and sag in the toughest power system with the best combination of fast switching, ruggedized design and cost-effectiveness.

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	800	V
V_{GS}	Gate-Source Voltage	±30	V
I_D@T_C=25℃	Continuous Drain Current, V_{GS} @ 10V	3.2	A
I_D@T_C=100℃	Continuous Drain Current, V_{GS} @ 10V	1.7	A
I_{DM}	Pulsed Drain Current[1]	12	A
P_D@T_C=25℃	Total Power Dissipation	34.7	W
E_{AS}	Single Pulse Avalanche Energy[3]	4.5	mJ
T_{STG}	Storage Temperature Range	-55 to 150	℃
T_J	Operating Junction Temperature Range	-55 to 150	℃

Thermal Data

Symbol	Parameter	Value	Units
Rthj-c	Maximum Thermal Resistance, Junction-case	3.6	℃/W
Rthj-a	Maximum Thermal Resistance, Junction-ambient	65	℃/W

Electrical Characteristics@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=250uA	800	-	-	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance[2]	V_{GS}=10V, I_D=1A	-	-	4.5	Ω
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=250uA	2	-	4	V
g_{fs}	Forward Transconductance	V_{DS}=10V, I_D=1A	-	2	-	S
I_{DSS}	Drain-Source Leakage Current	V_{DS}=640V, V_{GS}=0V	-	-	100	uA
I_{GSS}	Gate-Source Leakage	V_{GS}=±30V, V_{DS}=0V	-	-	±100	nA
Q_g	Total Gate Charge	I_D=1A	-	18	-	nC
Q_{gs}	Gate-Source Charge	V_{DS}=480V	-	3.8	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	V_{GS}=10V	-	6	-	nC
$t_{d(on)}$	Turn-on Delay Time	V_{DD}=300V	-	15	-	ns
t_r	Rise Time	I_D=1A	-	20	-	ns
$t_{d(off)}$	Turn-off Delay Time	R_G=50Ω	-	105	-	ns
t_f	Fall Time	V_{GS}=10V	-	30	-	ns
C_{iss}	Input Capacitance	V_{GS}=0V	-	800	1280	pF
C_{oss}	Output Capacitance	V_{DS}=25V	-	55	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	4	-	pF
R_g	Gate Resistance	f=1.0MHz	-	3.6	7.2	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage[2]	I_S=1.2A, V_{GS}=0V	-	-	1.5	V
t_{rr}	Reverse Recovery Time	I_S=1A, V_{GS}=0V	-	320	-	ns
Q_{rr}	Reverse Recovery Charge	dI/dt=100A/μs	-	1.3	-	μC

Notes:

1.Pulse width limited by max. junction temperature.

2.Pulse test

3.Starting T_j=25°C , V_{DD}=50V , L=1mH , R_G=25Ω , I_{AS}=3A

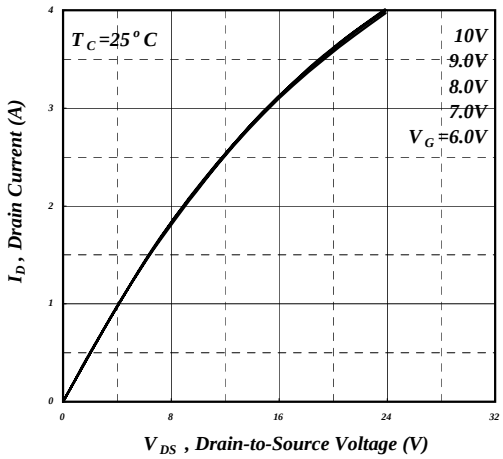


Fig 1. Typical Output Characteristics

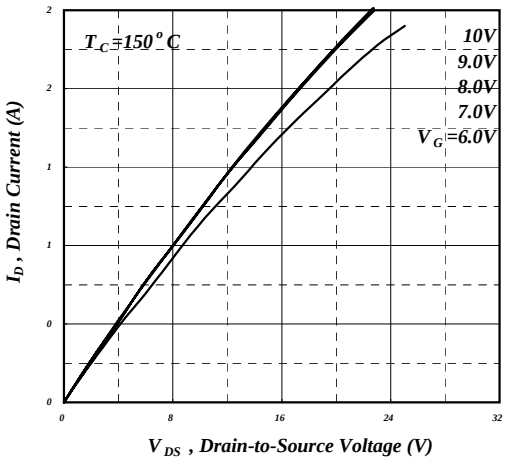


Fig 2. Typical Output Characteristics

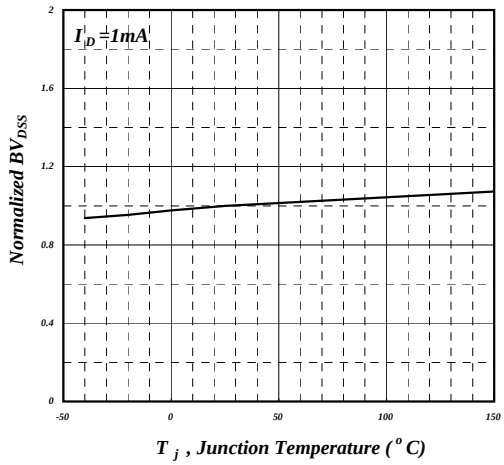


Fig 3. Normalized BV_{DSS} v.s. Junction Temperature

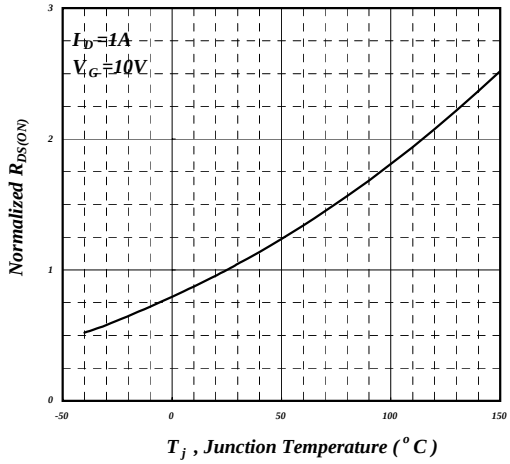


Fig 4. Normalized On-Resistance v.s. Junction Temperature

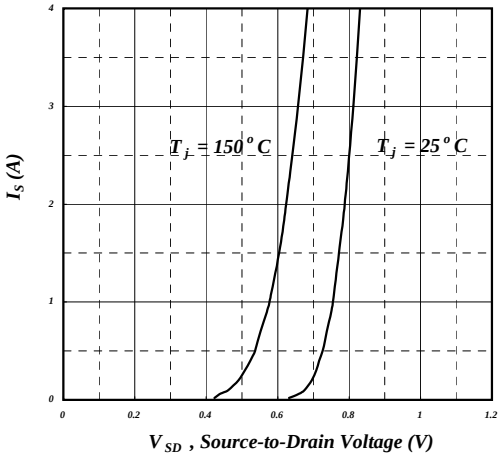


Fig 5. Forward Characteristic of Reverse Diode

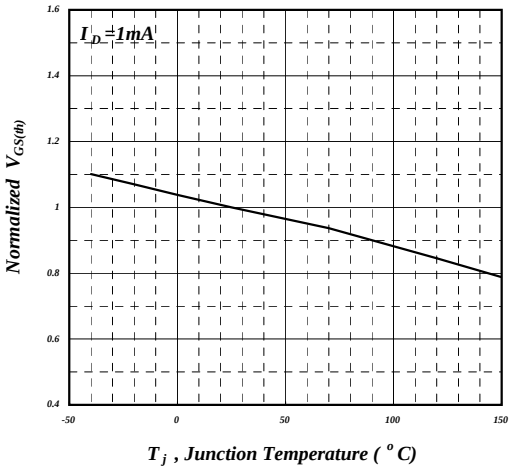


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

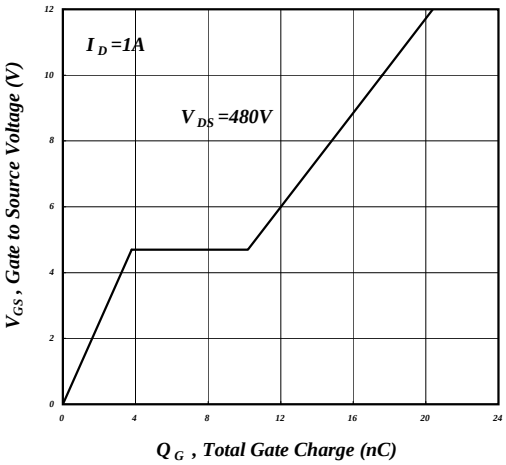


Fig 7. Gate Charge Characteristics

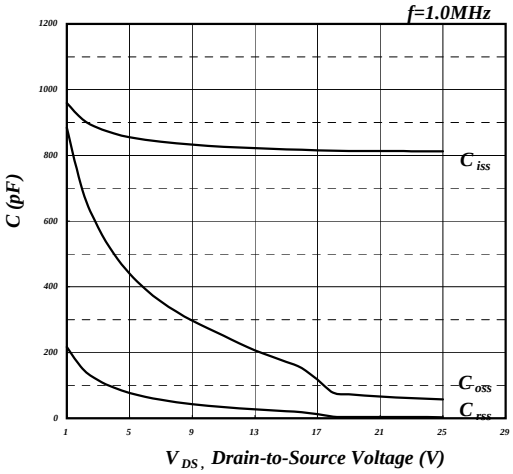


Fig 8. Typical Capacitance Characteristics

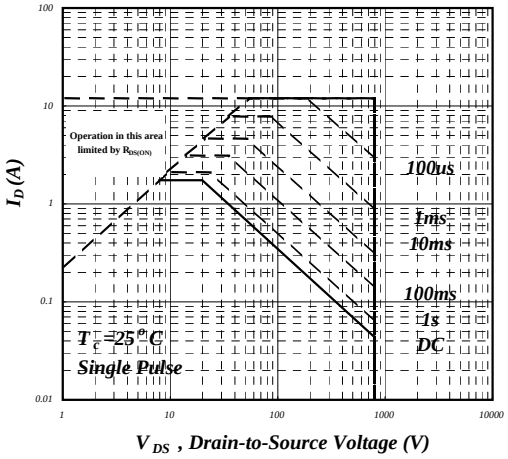


Fig 9. Maximum Safe Operating Area

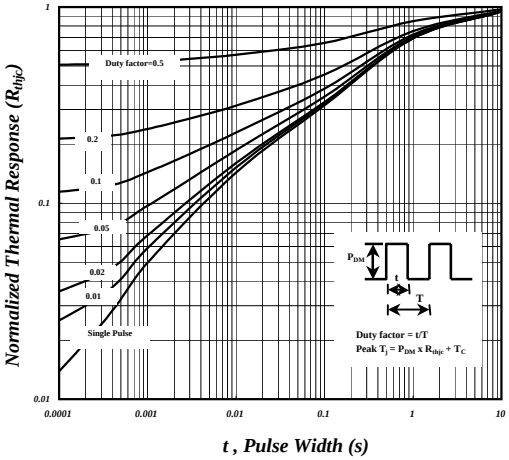


Fig 10. Effective Transient Thermal Impedance

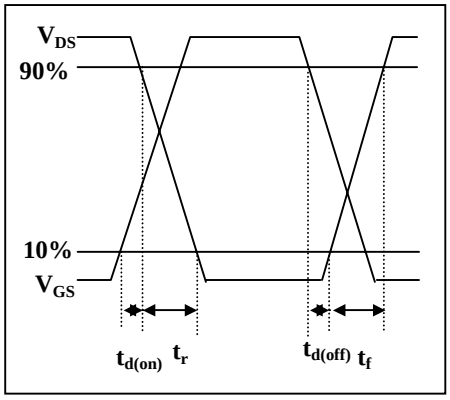


Fig 11. Switching Time Waveform

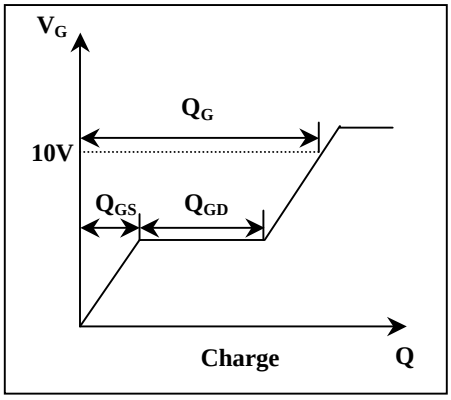


Fig 12. Gate Charge Waveform